Form PTO 1449 (Modified)				ATTY DOCKET NO.		SERIAL NO. /O/ 仏みみの N EW APPLICATION			
LIST OF	DEEED	ENCES CITED BY AD	PLICANT	APPLICANT		•			
LIST OF REFERENCES CITED BY APPLICANT				Hirofumi FUJII, et al.					
				FILING DATE	GROUP 1753				
				HEREWITH					
				U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS SUB- CLASS			FILING DATE IF APPROPRIATE	
	AA				<u> </u>				
	AB						_		
	AC				İ				
	AD								
	AE								
	AF								
	AG								
	AH		1			·			
	AI		 		0.				
	AJ			-	 				
	AK		 						
			-		 				
-	AL				 	 			
	AM				 	+			
	AN		<u> </u>	1	_L	1	l		
			FC	REIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSL		NO NO	
	AO	7-173617	07/11/95	Japan				x	
	AP	2000-80466	03/21/00	Japan				x	
SAV	AQ	EP 1 081 247 A2	08/18/00	Europe CJ3C /5	ope CJ3C 14/32			X	
JAV_	AR								
	AS				-				
	AT								
	AU								
	AV								
	1	OTHER F	REFERENCES	(Including Author, Title, Date, Pertine	nt Pages,	etc.)			
	AW								
	AX	-							
	AY								
	AZ				Ad	ditional Re	ferences s	heet(s) attached	
Examiner	- 1 - 0					Date Considered May 17, 2005			
]]	ستخصرت مراحتانها		d whather are	ot citation is in conformance with MPEP	600. Dtam	line through			
conformance	e and r	not considered. Include	copy of this fo	m with next communication to applicant					

. · •					OIPE	\				
					APR 0 6 2004	·/	SHE	ET 1	OF 1	
Form PTO 1449		U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO.			SERIAL NO.			
(Modified)		PATENT AND TRAC	EMARK OFFICE	ATTY DOCKET NO. 242588US3 & TRADE WART			10/662,280			
				APPLICANT						
LIST OF	REFER	RENCES CITED BY AP	PLICANT	Hirofumi FUJ	II, et al.					
				FILING DATE			GROUP			
				September 16, 2003			1753			
	•			U.S. PATENT DO	CUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER DATE		NAME		CLASS			ING DATE PROPRIATE	
	AA									
	AB									
	AC									
	AD									
	AE									
	AF									
	AG									
	AH								· - · · · · ·	
	Al		 							
	AJ									
	AK					<u> </u>				
	AL									
	AM									
	AN								·•	
			FO	REIGN PATENT	DOCUMENTS	<u> </u>	·		***************************************	
		DOCUMENT NUMBER	DATE		COUNTRY			OUT THATESTION WILL		
SHV	AO	0 658 634	06/21/1995	EUROPE			C230		1455	
	AP									
	AQ	•								
	AR									
	AS									
	ΑT									
	AU	<u> </u>							· · · · · · · · · · · · · · · · · · ·	
·	AV		<u> </u>						 	
		OTHER R	EFERENCES (Including Author	, Title, Date, Pertinent	t Pages, e	tc.)			
SHV	AW	Patent Abstracts of Ja	pan, JP 52-09	5581, August 11,	1977 ·					
SHV	AX	Patent Abstracts of Ja	pan, JP 06-22	0617, August 8, 19	394					
	AY									
	AZ					Addi	tional Refe	rences s	heet(s) attached	
Examiner	Jegve Q					Date Considered Thy 17,2005				
*Examiner: In conformance	itial if r and no	eference is considered, ot considered. Include c	whether or no opy of this form	t citation is in conf	ormance with MPEP 60 nication to applicant.	09; Draw li	ne through	citation if	f not in	